

10N60 / 10N60F

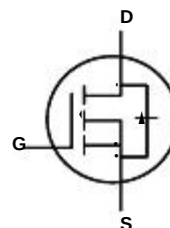
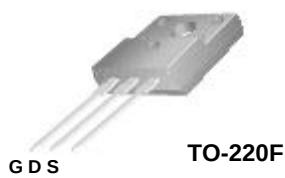
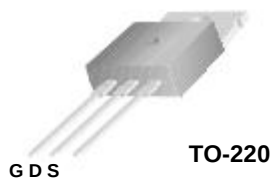
600V N-Channel MOSFET

General Description

This Power MOSFET is produced using SL semi's advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

Features

- 10.0A, 600V, $R_{DS(on)} = 0.750\Omega$ @ $V_{GS} = 10V$
- Low gate charge (typical 48nC)
- High ruggedness
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



Absolute Maximum Ratings

$T_c = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	JTM10N60	JTM10N60F	Units
V_{DS}	Drain-Source Voltage	600		V
I_D	Drain Current - Continuous ($T_c = 25^\circ\text{C}$)	10.0	10.0*	A
	- Continuous ($T_c = 100^\circ\text{C}$)	6.0	6.0*	A
I_{DM}	Drain Current - Pulsed (Note 1)	40	40 *	A
V_{GS}	Gate-Source Voltage	± 30		V
EAS	Single Pulsed Avalanche Energy (Note 2)	709		mJ
EAR	Repetitive Avalanche Energy (Note 1)	16.2		mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	4.5		V/ns
PD	Power Dissipation ($T_c = 25^\circ\text{C}$)	162	52	W
	- Derate above 25°C	1.30	0.42	W/ $^\circ\text{C}$
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to $+150$		$^\circ\text{C}$
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300		$^\circ\text{C}$

* Drain current limited by maximum junction temperature.

Thermal Characteristics

Symbol	Parameter	JTM10N60	JTM10N60F	Units
R_{JC}	Thermal Resistance, Junction-to-Case	0.77	2.4	$^\circ\text{C/W}$
R_{CS}	Thermal Resistance, Case-to-Sink Typ.	0.5	--	$^\circ\text{C/W}$
R_{JA}	Thermal Resistance, Junction-to-Ambient	62.5	62.5	$^\circ\text{C/W}$

JTM10N60 / JTM10N60F

Electrical Characteristics

T_c = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BVDSS	Drain-Source Breakdown Voltage	VGS = 0 V, ID = 250 μ A	600	--	--	V
$\square$ BVDSS / $\square$ TJ	Breakdown Voltage Temperature Coefficient	ID = 250 μ A, Referenced to 25°C	--	0.7	--	V/°C
IDSS	Zero Gate Voltage Drain Current	VDS = 600 V, VGS = 0 V	--	--	1	μ A
		VDS = 480 V, TC = 125°C	--	--	10	μ A
IGSSF	Gate-Body Leakage Current, Forward	VGS = 30 V, VDS = 0 V	--	--	100	nA
IGSSR	Gate-Body Leakage Current, Reverse	VGS = -30 V, VDS = 0 V	--	--	-100	nA
On Characteristics						
VGS(th)	Gate Threshold Voltage	VDS = VGS, ID = 250 μ A	2.0	--	4.0	V
RDS(on)	Static Drain-Source On-Resistance	VGS = 10 V, ID = 5.0A	--	0.62	0.75	Ω
Dynamic Characteristics						
Ciss	Input Capacitance	VDS = 25 V, VGS = 0 V, f = 1.0 MHz	--	1650	--	pF
Coss	Output Capacitance		--	165	--	pF
Crss	Reverse Transfer Capacitance		--	18	--	pF
Switching Characteristics						
td(on)	Turn-On Delay Time	VDD = 300 V, ID = 10.0A, RG = 25 Ω (Note 4, 5)	--	25	--	ns
tr	Turn-On Rise Time		--	70	--	ns
td(off)	Turn-Off Delay Time		--	140	--	ns
tf	Turn-Off Fall Time		--	80	--	ns
Qg	Total Gate Charge	VDS = 480 V, ID = 10.0A, VGS = 10 V (Note 4, 5)	--	48	-	nC
Qgs	Gate-Source Charge		--	7.0	--	nC
Qgd	Gate-Drain Charge		--	18.0	--	nC
Drain-Source Diode Characteristics and Maximum Ratings						
IS	Maximum Continuous Drain-Source Diode Forward Current		--	--	10.0	A
ISM	Maximum Pulsed Drain-Source Diode Forward Current		--	--	40.0	A
VSD	Drain-Source Diode Forward Voltage	VGS = 0 V, IS = 10.0 A	--	--	1.4	V
trr	Reverse Recovery Time	VGS = 0 V, IS = 10.0 A,	--	430	--	ns
Qrr	Reverse Recovery Charge	dIF / dt = 100 A/ μ s (Note 4)	--	4.3	--	μ C

Notes:

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. L = 13mH, I_{AS} = 10.0 A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C
3. I_{SD} δ 10.0 A, di/dt δ 200A/ μ s, V_{DD} δ BV_{oss}, Starting T_J = 25°C
4. Pulse Test : Pulse width δ 300 μ s, Duty cycle δ 2%
5. Essentially independent of operating temperature

Typical Characteristics

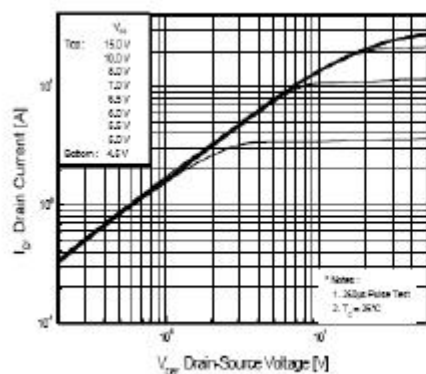


Figure 1. On-Region Characteristics

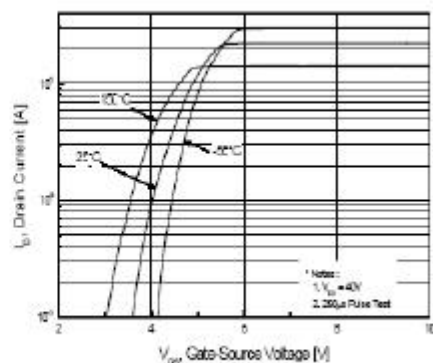


Figure 2. Transfer Characteristics

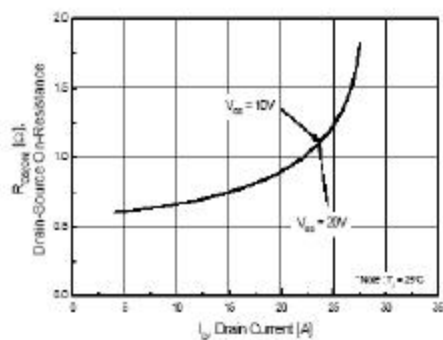


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

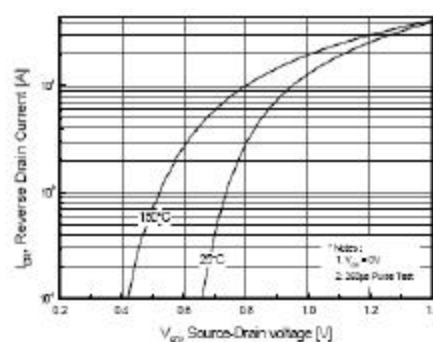


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

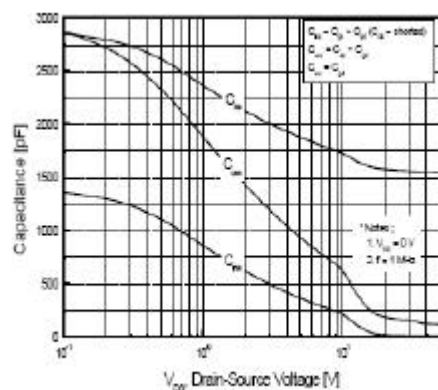


Figure 5. Capacitance Characteristics

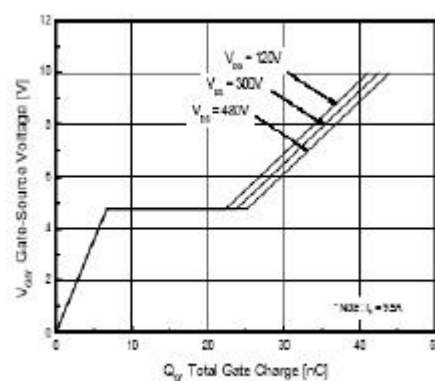


Figure 6. Gate Charge Characteristics

Typical Characteristics (Continued)

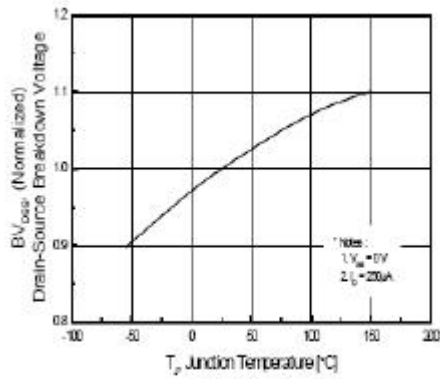


Figure 7. Breakdown Voltage Variation vs Temperature

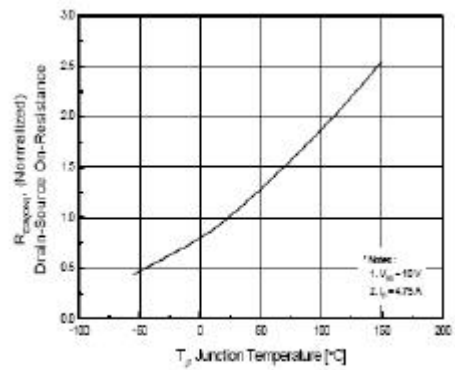


Figure 8. On-Resistance Variation vs Temperature

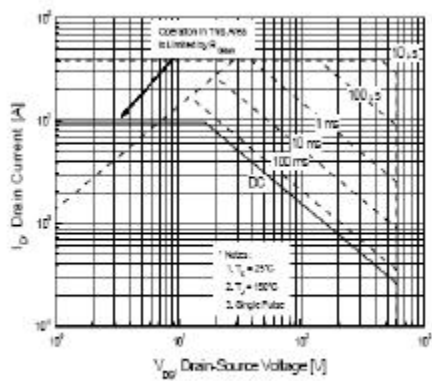


Figure 9-1. Maximum Safe Operating Area for JTM10N60

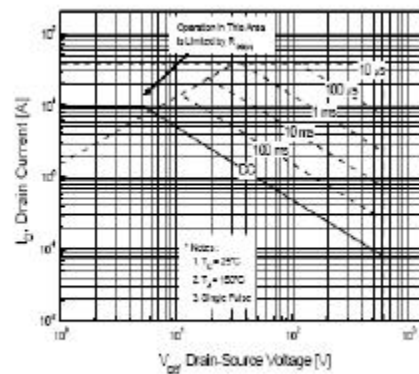


Figure 9-2. Maximum Safe Operating Area for JTM10N60F

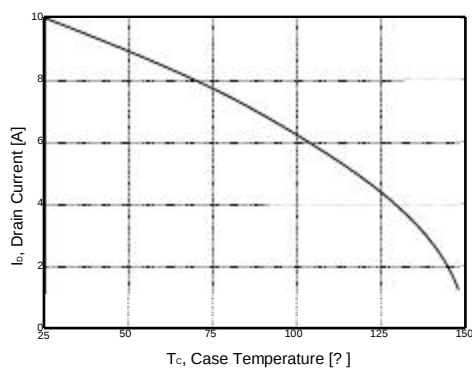


Figure 10. Maximum Drain Current vs Case Temperature

Typical Characteristics (Continued)

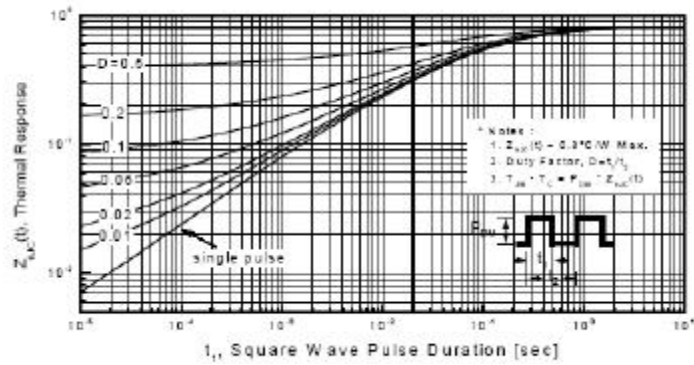


Figure 11-1. Transient Thermal Response Curve
for JTM10N60

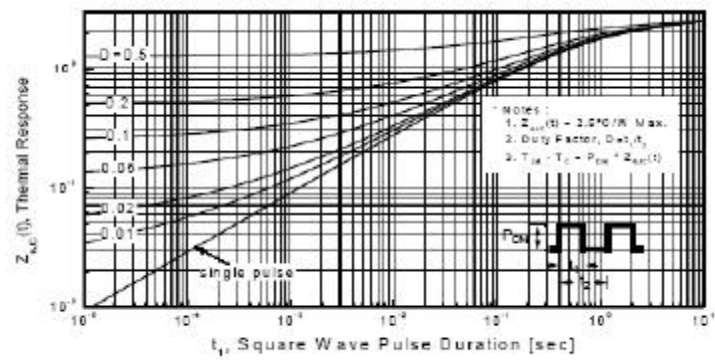
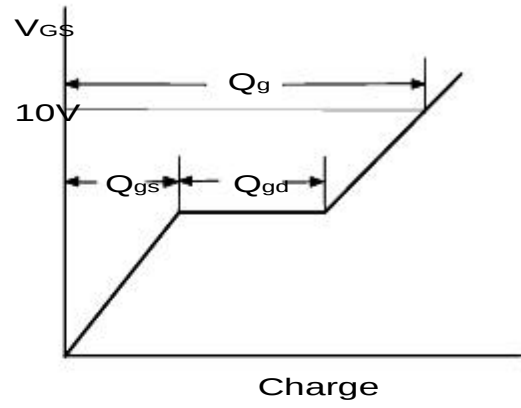
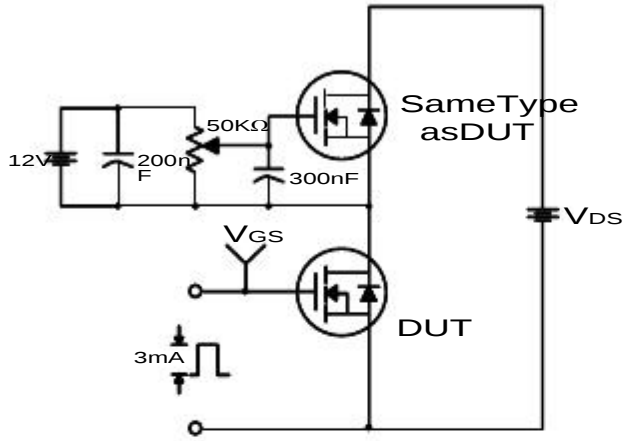
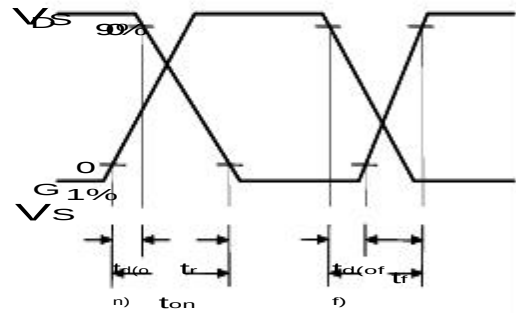
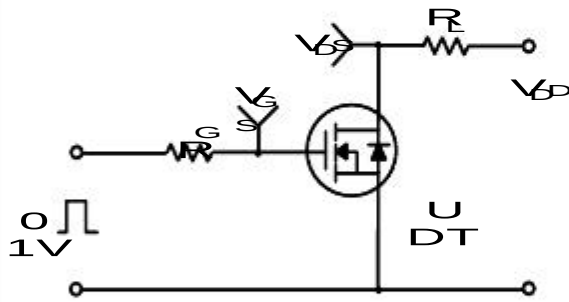


Figure 11-2. Transient Thermal Response Curve
for JTM10N60F

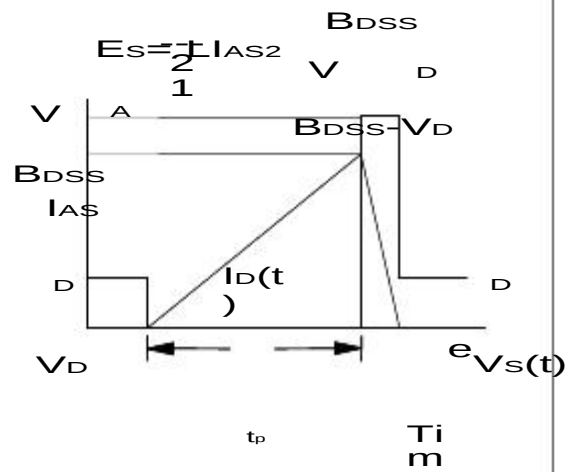
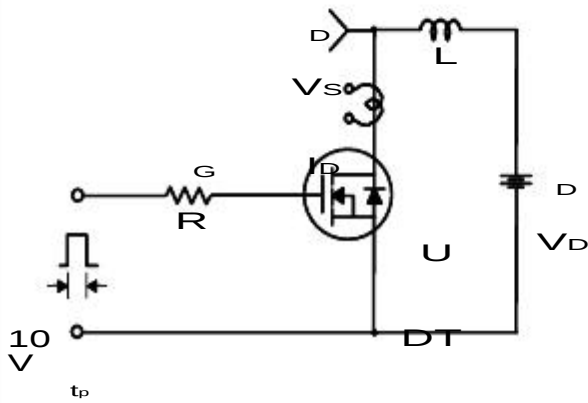
Gate Charge Test Circuit & Waveform



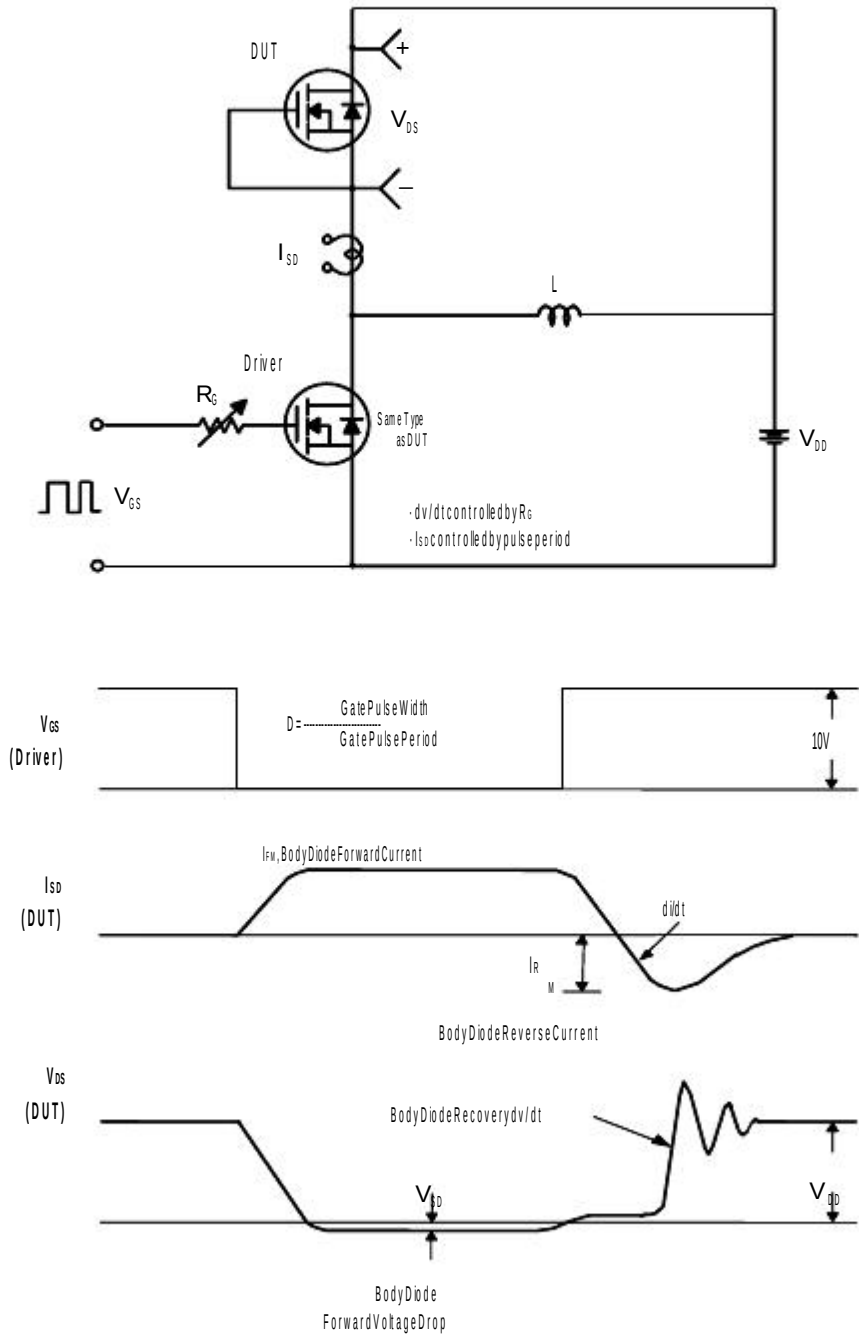
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms



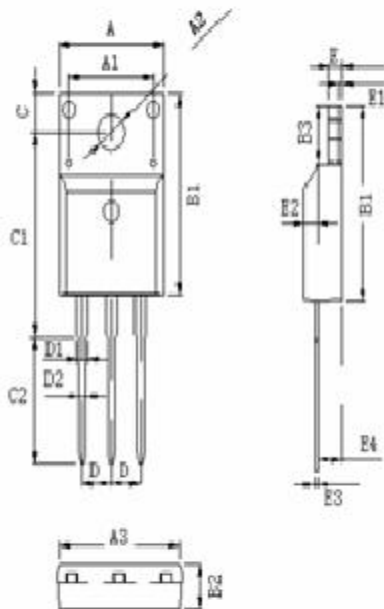
Peak Diode Recovery dv/dt Test Circuit & Waveforms



Package Dimensions

TO-220F

TO-220F 外形尺寸图



DIM.	MILLIMETERS.	
A.	10.03 ± 0.20.	
A1.	7.00.	
A2.	3.12 ± 0.10.	
A3.	9.70 ± 0.20.	
B1.	15.75 ± 0.20.	
B2.	4.72 ± 0.20.	
B3.	6.70 ± 0.20.	
C.	3.30 ± 0.10.	
C1.	15.80 ± 0.20.	
C2.	9.80 ± 0.2.	
D.	Typical 2.54.	
D1.	1.47 (MAX).	
D2.	0.80 ± 0.10.	
E.	2.55 ± 0.20.	
E1.	0.70.	
E2.	1.00 × 45°.	
E3.	0.50.	+0.1. -0.05.
E4.	2.80 ± 0.20.	